

Search Notes

Application/Control No.

10/750,845

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

KANG ET AL.

Art Unit

1795

SEARCHED

Class	Subclass	Date	Examiner
430	326	12/2007	JSC
430	191		
430	192		
430	193		
430	270.1		
427	57		
427	240		
427	241		
427	346		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
UPDATED	12/2007	JSC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
430	326,270.1	12/2007	JSC
430	191,192		
430	193		
427/57,240,241,346			